

**Search Notes**

Application/Control No.

10/816,686

Examiner

Matthew G. Kayrish

Applicant(s)/Patent under  
Reexamination

CHANG ET AL.

Art Unit

2627

**SEARCHED**

Class	Subclass	Date	Examiner
360	264.7	10/24/2006	MK
360	265.8	10/24/2006	MK
360	264.8	10/24/2006	MK
360	265.7	10/24/2006	MK
720	662	10/24/2006	MK
360	265	10/24/2006	MK
360	264.2	10/24/2006	MK

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (USPG-PUB, USPAT, USOCR, EPO, JPO, IBM_TDB, DERWENT, FPRS) (See Attached Search History)	10/24/2006	MK